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(Modified)		PATENT AND TRAD	DEMARK OFFICE	285079US6X PCT					
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	AY								
	AZ	Additional References sheet(s) attached							
Examiner		 /Simon Nguyen/				Date Considered 09/21/2010			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									